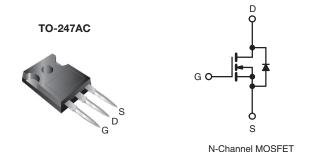


Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	10	100				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	0.055				
Q _g (Max.) (nC)	14	140				
Q _{gs} (nC)	2	9				
Q _{gd} (nC)	68					
Configuration	Single					



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- 175 °C Operating Temperature
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247AC package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220AB devices. The TO-247AC is similar but superior to the earlier TO-218 package because its isolated mounting hole. It also provides greater creepage distances between pins to meet the requirements of most safety specifications.

ORDERING INFORMATION			
Package	TO-247AC		
Lead (Pb)-free	IRFP150PbF		
	SiHFP150-E3		
SnPb	IRFP150		
	SiHFP150		

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	100		
Gate-Source Voltage			V _{GS}	± 20	V	
Continuous Drain Current	V at 10 V	T _C = 25 °C	,	41	А	
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	I _D	29		
Pulsed Drain Current ^a			I _{DM}	160		
Linear Derating Factor				1.5	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	830	mJ	
Repetitive Avalanche Current ^a			I _{AR}	41	Α	
Repetitive Avalanche Energy ^a			E _{AR}	19	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	230	W	
Peak Diode Recovery dV/dtc			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d		
Mounting Torque	6 22 or N	C 00 av M0 assess		10	lbf ⋅ in	
Mounting Torque	6-32 or M3 screw			1.1	N·m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 740 μ H, R_g = 25 Ω , I_{AS} = 41 A (see fig. 12). c. I_{SD} \leq 41 A, dl/dt \leq 300 A/ μ s, V_{DD} \leq V_{DS}, T_J \leq 175 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	40		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.65		

SPECIFICATIONS ($T_J = 25 ^{\circ}C$, u	nless otherw	rise noted)					
PARAMETER	SYMBOL	TEST CONDITIONS			TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0	V, I _D = 250 μA	100	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	o 25 °C, I _D = 1 mA	-	0.14	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_0$	_{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V _G :	S = ± 20 V	-	-	± 100	nA
Zon Oak Walkers Buris O and		V _{DS} = 10	00 V, V _{GS} = 0 V	-	-	25	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 80 \text{ V}, V_{0}$	_{GS} = 0 V, T _J = 150 °C	-	-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 25 A ^b	-	-	0.055	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 2	5 V, I _D = 25 A ^b	13	-	-	S
Dynamic							
Input Capacitance	C _{iss}	V 0V		-	2800	-	
Output Capacitance	C _{oss}	V _C	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		1100	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	280	-	
Total Gate Charge	Qg			-	-	140	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	29	nC
Gate-Drain Charge	Q _{gd}		see fig. 6 and 135		-	68	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 50 \text{ V}, I_{D} = 41 \text{ A},$ $R_{g} = 6.2 \Omega, R_{D} = 1.2 \Omega, \text{ see fig. } 10^{b}$		-	16	-	- ns
Rise Time	t _r			-	120	-	
Turn-Off Delay Time	t _{d(off)}			-	60	-	
Fall Time	t _f			-	81	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	
Internal Source Inductance	L _S			-	13	-	- nH
Drain-Source Body Diode Characteristic	s			·	·		
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	41	_
Pulsed Diode Forward Current ^a	I _{SM}			-	-	160	A
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 41 A, V _{GS} = 0 V ^b		-	-	2.5	V
Body Diode Reverse Recovery Time	t _{rr}	T 05 00 1	44 A -11/-11 - 400 A / b	-	220	330	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 41 \text{A, dl/dt} = 100 \text{A/}\mu\text{s}^b$		-	1.9	2.9	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L				T D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

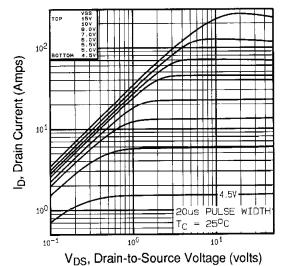


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

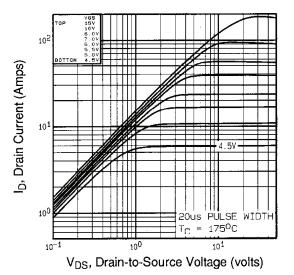


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

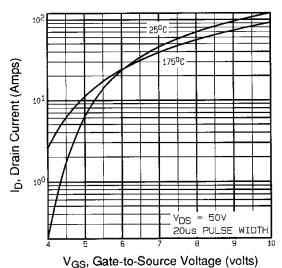
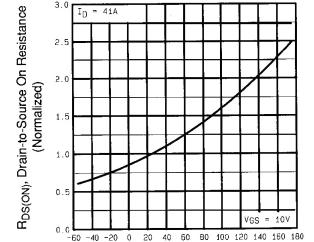


Fig. 3 - Typical Transfer Characteristics



T_J, Junction Temperature (°C) Fig. 4 - Normalized On-Resistance vs. Temperature



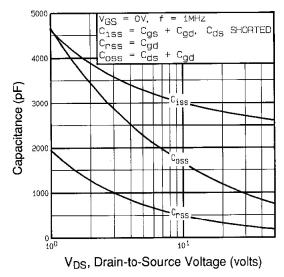


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

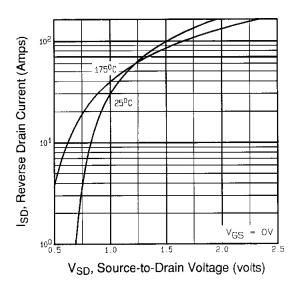


Fig. 7 - Typical Source-Drain Diode Forward Voltage

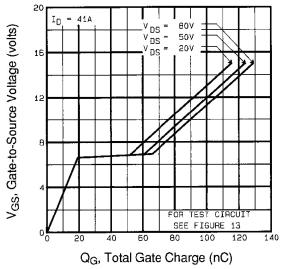


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

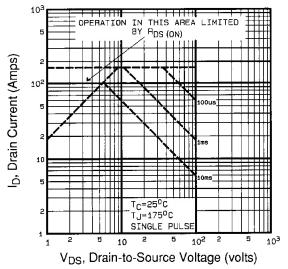


Fig. 8 - Maximum Safe Operating Area





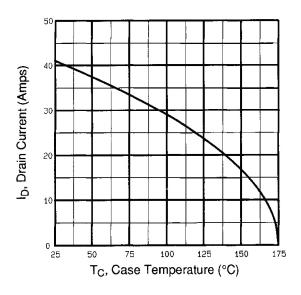


Fig. 9 - Maximum Drain Current vs. Case Temperature

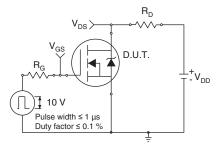


Fig. 10a - Switching Time Test Circuit

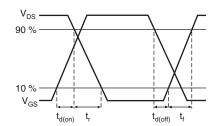


Fig. 10b - Switching Time Waveforms

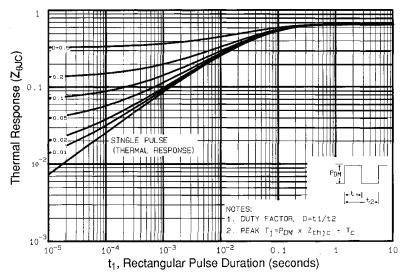


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



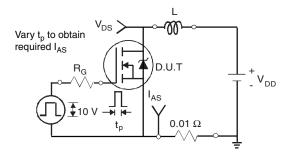


Fig. 12a - Unclamped Inductive Test Circuit

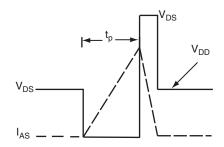


Fig. 12b - Unclamped Inductive Waveforms

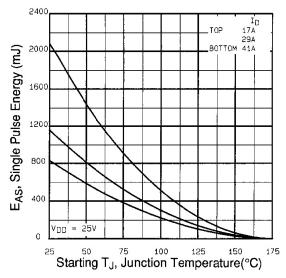


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

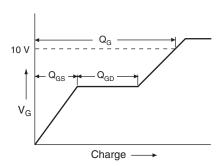


Fig. 13a - Basic Gate Charge Waveform

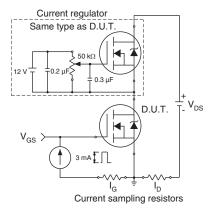
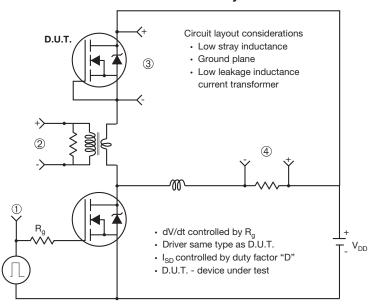


Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit



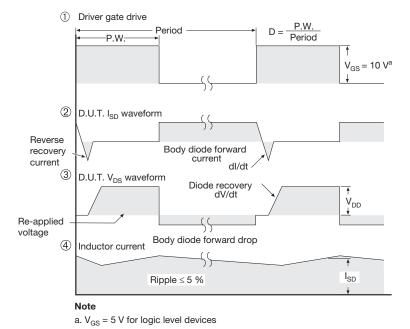
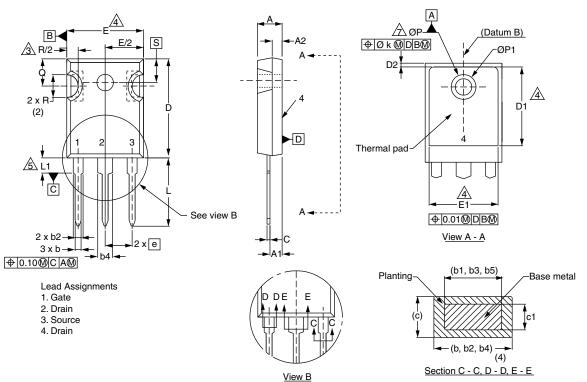


Fig. 14 - For N-Channel

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TO-247AC (High Voltage)



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.58	5.31	0.180	0.209
A1	2.21	2.59	0.087	0.102
A2	1.17	2.49	0.046	0.098
b	0.99	1.40	0.039	0.055
b1	0.99	1.35	0.039	0.053
b2	1.53	2.39	0.060	0.094
b3	1.65	2.37	0.065	0.093
b4	2.42	3.43	0.095	0.135
b5	2.59	3.38	0.102	0.133
С	0.38	0.86	0.015	0.034
c1	0.38	0.76	0.015	0.030
D	19.71	20.82	0.776	0.820
D1	13.08	-	0.515	-

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D2	0.51	1.30	0.020	0.051
E	15.29	15.87	0.602	0.625
E1	13.72	ı	0.540	1
е	5.46	BSC	0.215	BSC
Øk	0.254		0.010	
L	14.20	16.25	0.559	0.640
L1	3.71	4.29	0.146	0.169
N	7.62	BSC	0.300	BSC
ØΡ	3.51	3.66	0.138	0.144
Ø P1	-	7.39	-	0.291
Q	5.31	5.69	0.209	0.224
R	4.52	5.49	0.178	0.216
S	5.51 BSC		0.217	BSC

ECN: X13-0103-Rev. D, 01-Jul-13 DWG: 5971

Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Contour of slot optional.
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.
- 4. Thermal pad contour optional with dimensions D1 and E1.
 5. Lead finish uncontrolled in L1.
- 6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").
- 7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.
- 8. Xian and Mingxin actually photo.



Revision: 01-Jul-13 Document Number: 91360



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Revision: 02-Oct-12 Document Number: 91000